Connected Productivity in the Materials Lab

ZEISS ZEN core

Software Suite for Connected Microscopy in Material Laboratories

zeiss.com/zen-core

ZEISS

Seeing beyond

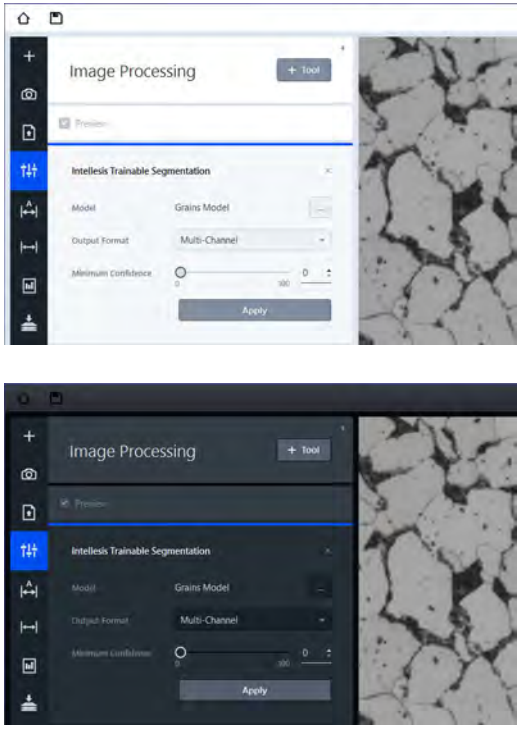
Imaging Software for Connected Microscopy in Material Laboratories

ZEN core is a powerful software suite for microscopy imaging, automated control of motorized ZEISS microscopes, and multi-modal workflows in material laboratory environments.

Use ZEN core to handle routine tasks on a wide range of ZEISS microscope and camera systems. While extracting the highest technical performance from your microscopes, ZEN core provides access to every parameter and function you might wish to optimize through an intuitive and configurable graphical interface.

Create task-specific workbenches that show only the required microscope controls on the screen. Combine these workbenches to create dedicated jobs that assist your operators through a defined flow of consecutive tasks, to ensure data repeatability in a multi-user environment.

ZEN core helps you to make your laboratory even more productive. With workflow and infrastructure solutions that connect data from different microscopes, ZEN core delivers more meaningful information in the form of correlated multi-scale and/or multi-modal characterization data. And thanks to its database connectivity features, you keep your valuable data together across instruments, laboratories, and locations.



The ZEN core user interface provides both a bright and a dark mode to meet the needs of different users and their preferred working environment.

Simpler. More Intelligent. More Integrated.

Easy to Configure. Easy to Use.

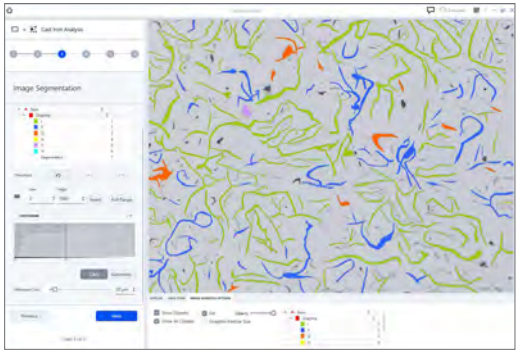
ZEN core gives you the benefit of an adaptive user interface tailored to the needs of industrial and research environments. The easy-to-follow GUI configuration accommodates tasks of all kinds and any complexity. ZEN core also offers you configurable user management, so you can specify users and user roles. Whatever their level of experience, operators will learn the software quickly. Using the ZEISS Word Add-In lets you easily create user configured report templates in MS Word®. The reporting functionality exports reports to various file formats including PDF or DOCX.

Advanced Imaging and Automated Analysis

ZEN core is the command center for automated imaging and analysis functions on compound light microscopes. By using built-in automated image acquisition routines, such as HDR or Best Image, you benefit from the consistency of an advanced and repeatable workflow. ZEN core provides automated image segmentation based on machine learning algorithms, as well as analysis functionality such as phase analysis or particle counting. Application-specific modules enhance your microscope to answer typical questions about the material structure in research and quality control.

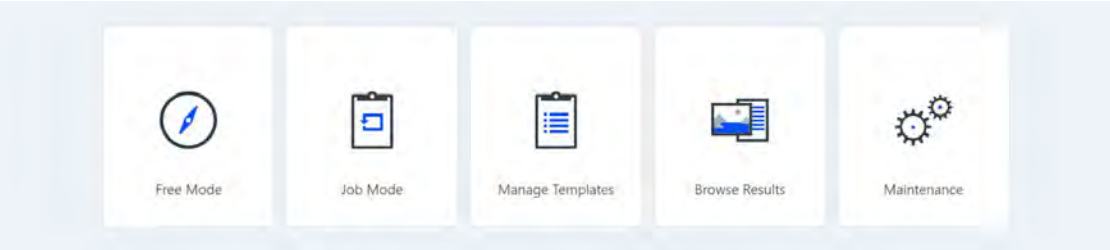
Infrastructure Solution for the Connected Laboratory

ZEN core provides the infrastructure for connected laboratory environments, linking all your ZEISS imaging and microscope solutions to a single, familiar GUI. ZEN core is also the interface to the ZEISS Axiocam camera portfolio, safeguarding an open connected laboratory architecture for 3rd party solutions. ZEN core bridges different forms of light and electron microscopy, improving productivity and multi-modal data integrity. Data management and database connectivity features help you to keep your valuable analysis data together across instruments, laboratories, and locations.



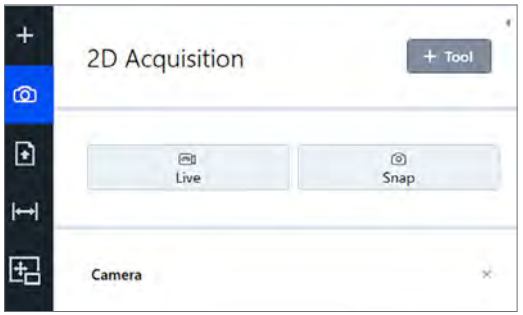
ZEISS ZEN core at Work

Standard Features

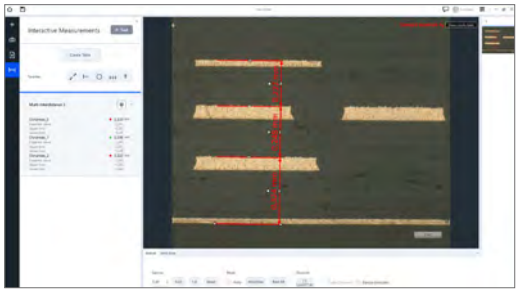


ZEN core home screen: Access to image acquisition and job functions

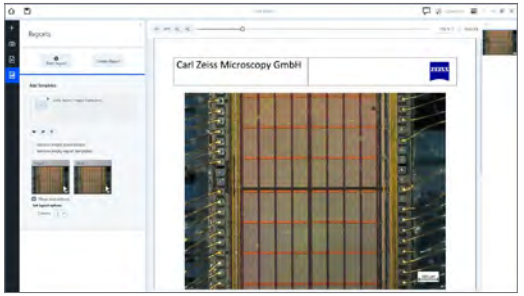
- Full operational control of ZEISS microscopes, cameras, and components
- Workbenches for repetitive application tasks
- Single and automated panorama image acquisition
- User management functionality
- High Dynamic Range (HDR) image acquisition
- Create and manage input forms
- Live image video recording
- Image and data information displayed in datazone below the image
- Best Image functionality
- Enhanced depth of field via manual focus
- Measurement functions
- Microsoft Word® reports and report templates
- Data archive for images, documents and templates
- Image export to all standard image formats such as JPG, BMP, TIFF
- Connection to ConfoMap
- Extended workflow capabilities, loop functionality



Preconfigured workbench



Measurement functions



Reporting template

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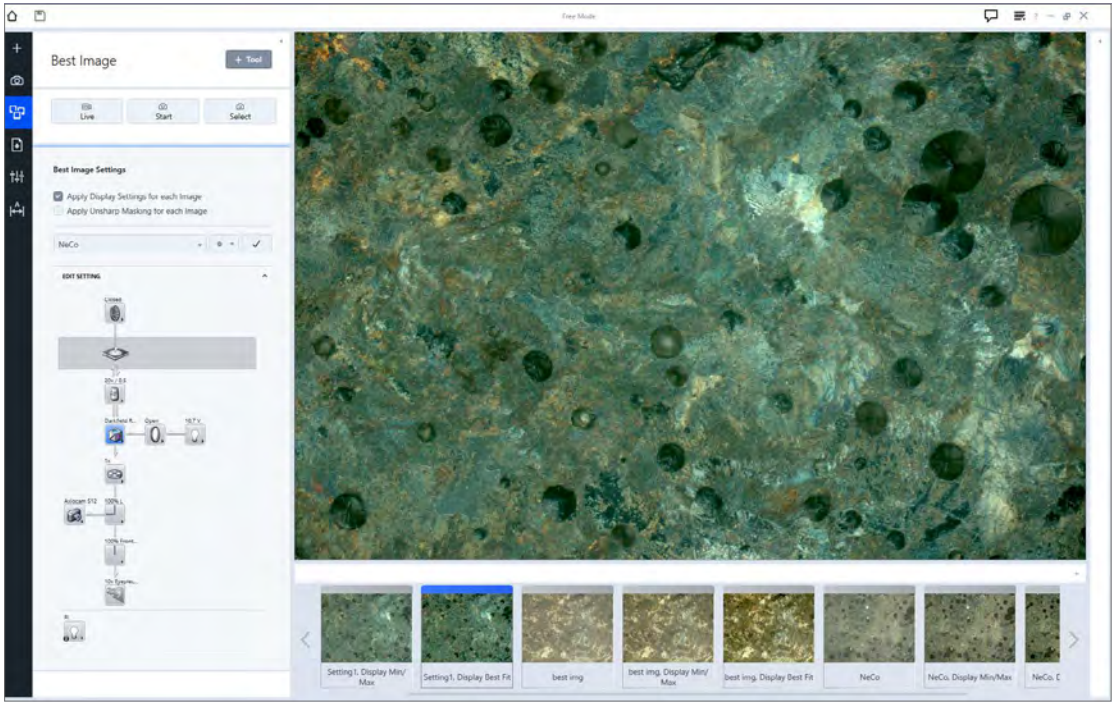
Automation for Compound Light Microscopes

Obtain results – rapidly and repeatably. ZEN core provides you with a wide range of choices for automated image acquisition:

- Best Image: assists you with the optimum microscope settings for image acquisition.
- HDR: ensures best image quality even with challenging light conditions.
- Panorama and Tiles: create stitched images in just a few clicks.
- Autofocus: automatically determine the perfect focus position for your sample.
- EDF: Automatically acquire multiple images at different focus positions and combine them to an image with enhanced depth of field.



Best Image workbench generates several images by applying different microscope presets. The user can choose the best image.

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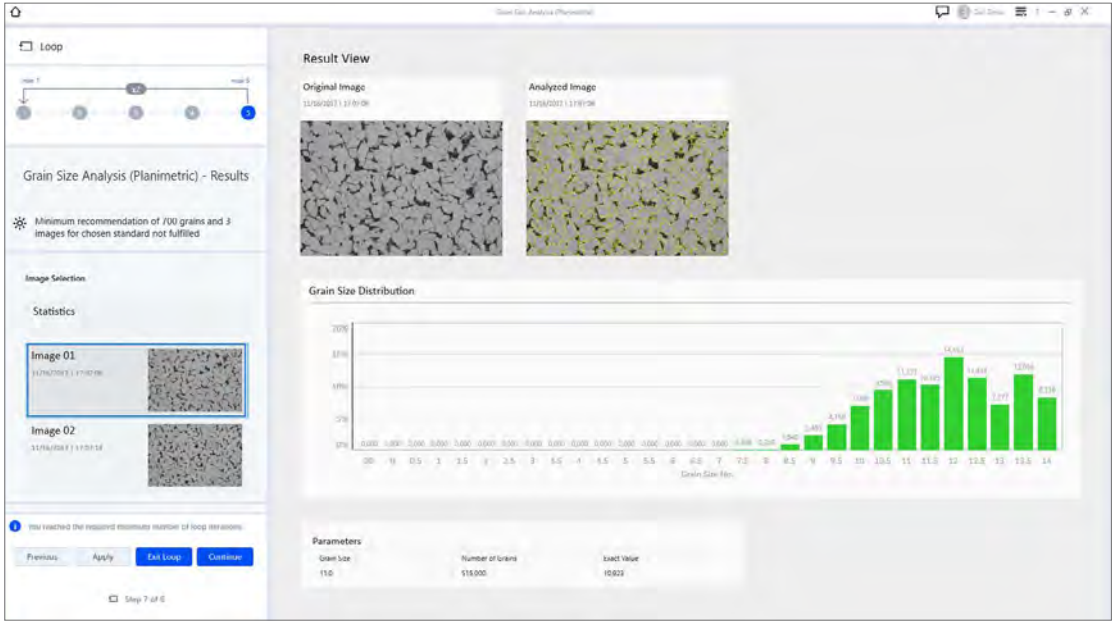
Grain Size Analysis

- The size and distribution of grains are directly linked to the material properties. Quantify the crystallographic structure of your materialographic samples in accordance to international standards. Three evaluation methods allow you to characterize your material:

- **Planimetric method** for automatic grain boundary reconstruction
- **Intercept method** with a variety of different chord patterns to interactively recognize and count the intersections with grain boundaries
- **Comparison method** for manual image evaluation with comparative diagrams

Supported Standards:

- DIN EN ISO 643:2012
- ASTM E 112-13
- ASTM E 1382-97
- GB/T 6394 2017 Plate I-V
- the segmentation of the image can be performed by lates machine learning algorithms



Planimetric Grain Size Analysis – result view

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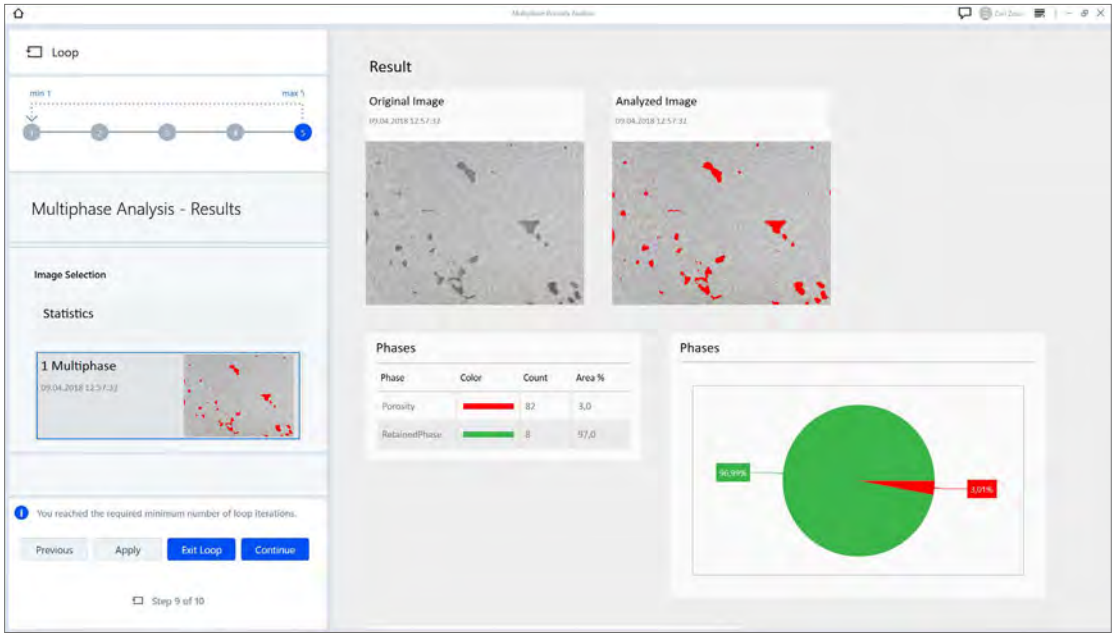
Multiphase Analysis

Any part of the material with a distinct crystal structure can be taken as a “phase”. Different phases are separated from one another by distinct boundaries. Distribution and orientation of phases affect the material properties like hardness, strength or elongation at break.

Analyze the phase distribution in your samples. Determine size, shape or orientation precisely and fully automatically. Use this distribution analysis to gain information about porosity of additive manufactured material.



Multiphase Analysis – result view with distribution of different phases

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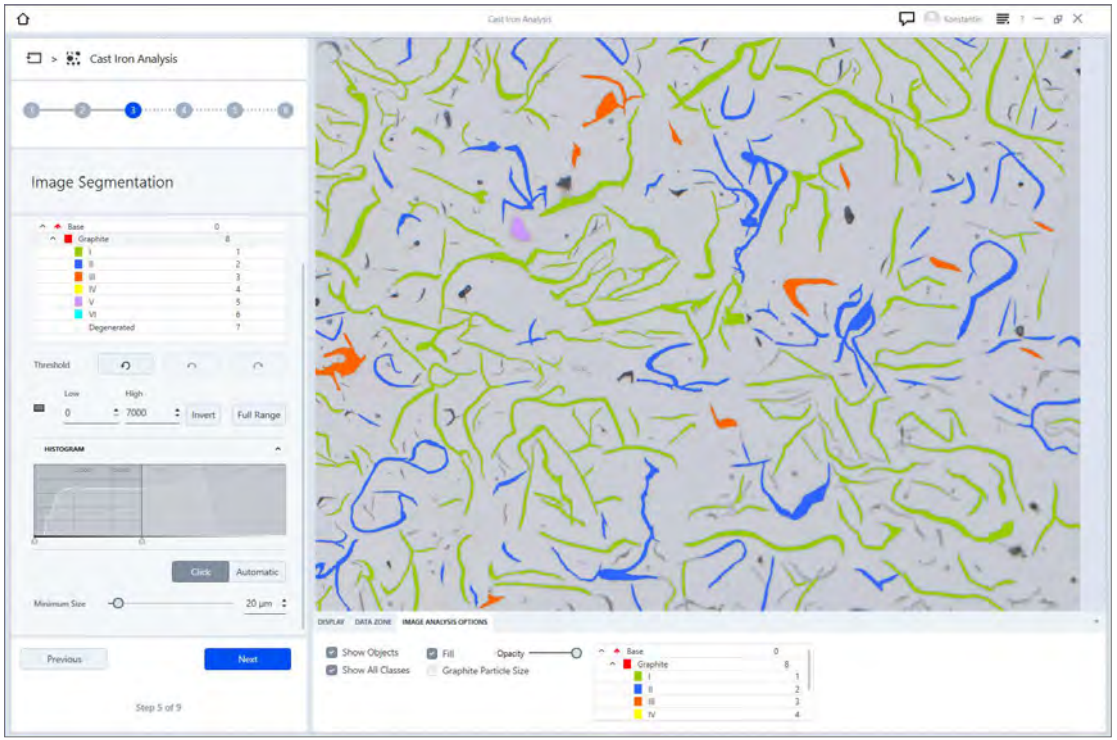
Cast Iron Analysis

Depending on process parameters and chemical composition of the material, graphite particles in cast iron can occur in different shape and distribution. This influences the mechanical properties of the material.

Analyze the shape and size of graphite particles fully automatically. Obtain the spheroid number according to DIN EN ISO 945 (2019). Determine the nodularity of vermicular graphite and examine the content of graphite particles in area percentage.



Cast Iron Analysis – image segmentation step

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Layer Thickness Measurement

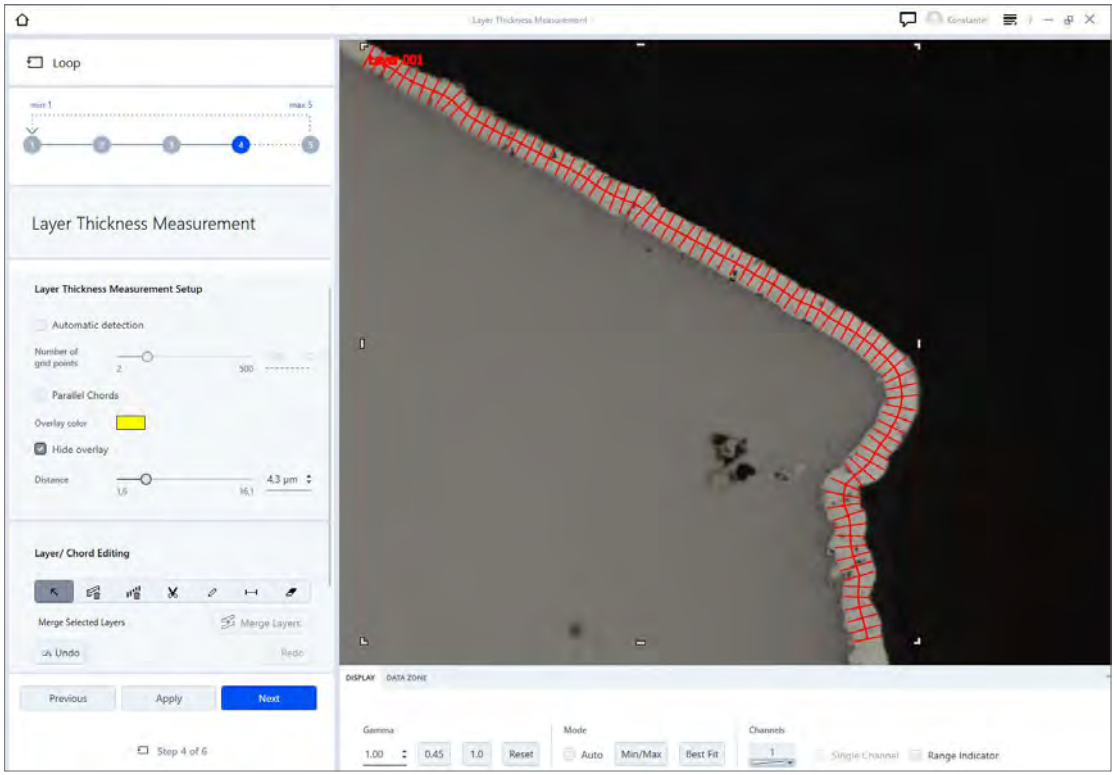
Measure thickness of coatings and platings, or the depth of hardened surfaces in the cross section of a sample.

Evaluate complex layers systems either automatically or interactively. The module calculates the course of the measurement chords depending on the gradient present.

Get the results from your part in a clearly report containing images, sample data and measurement values, such as the maximum and minimum chord lengths, mean, and standard deviation.

Supported Standards:

- DIN EN ISO 1463 - 2004
- ASTM B 487 - 2007



Layer Thickness Measurement – automatic detection of a layer

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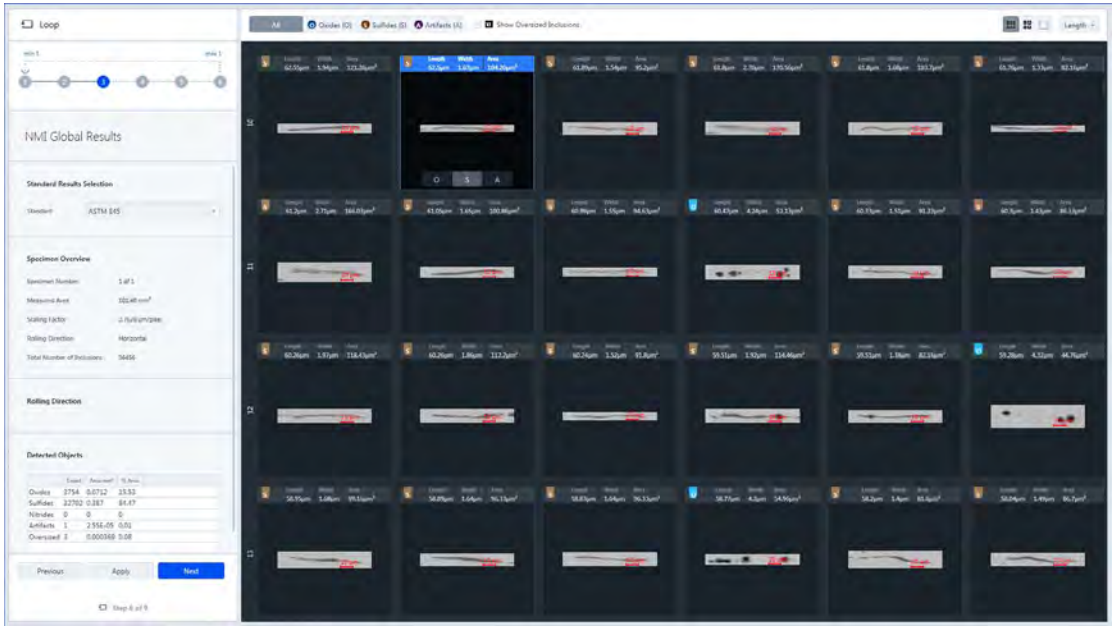
Non-Metallic Inclusion Analysis

The type and amount of non-metallic inclusions (NMI) in steels strongly affect the mechanical and physical properties of these steels.

Metallographic analysis of NMI is governed by industry standards that are supported by the modular and customizable ZEN core software which guides the user quickly and easily through the workflow, generating a report and inclusion gallery compliant with the standards.

ZEISS ZEN module Non-Metallic Inclusion Analysis confirms that manufacturing processes, grade and quality of the product meet strict specifications for impurities or defects that can cause a component to fail or impact its tensile strength, toughness and fatigue.

Powerful inspection views and automated deformation axis detection features make analysis easy, intuitive and repeatable. With additional GxP functionality, ZEN core users are able to offer their customers full traceability and data integrity in NMI analyses, meaning that grade certification is auditable, particularly advantageous for customers in regulated industries.



NMI user interface: Global Results view providing the option to toggle between the display of inclusion types oxides, sulfides, and artifacts.

Supported Standards

ASTM E45
ISO 4967
JIS G0555
GB/T 10561
EN 10247
SEP 1571
DIN 50602

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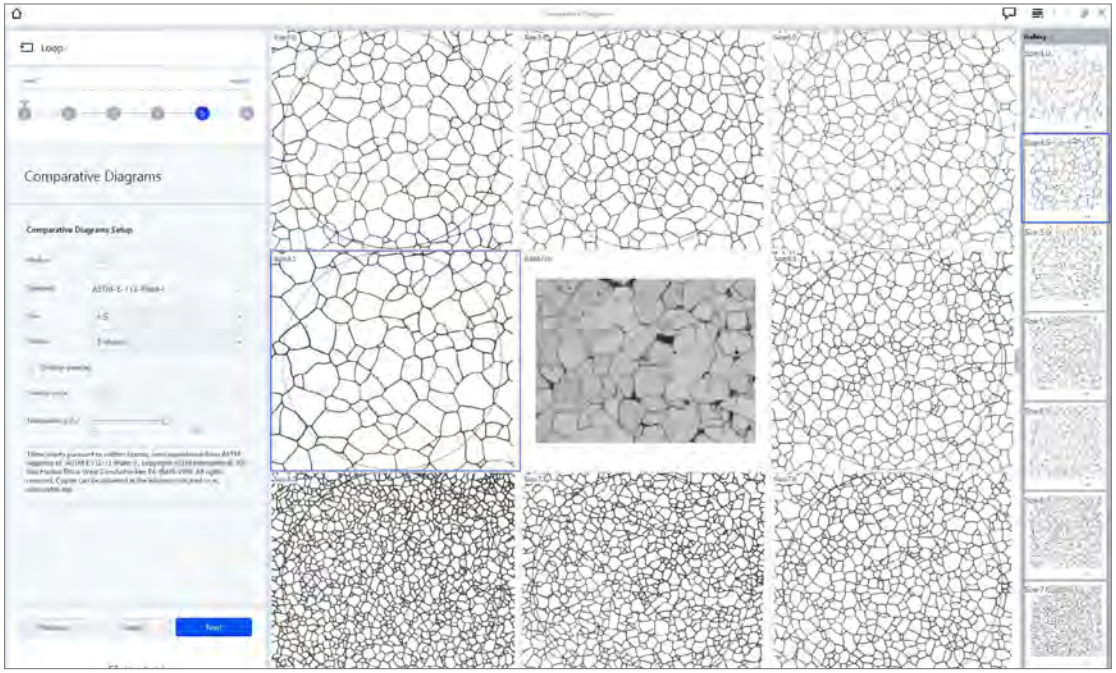
Comparative Diagrams

Make your Wall Charts digital. Compare your sample under the microscope with comparative diagrams directly on your screen. Choose between different schematic micrographs with specific characteristics. These change gradually from image to image and may relate to grain size, carbide precipitation in steel, or quality of sample preparation. The module also provides a chart series creator to design your own comparison diagrams, e.g. for pass-/fail criteria in quality control or best target preparation images for your individual material microstructures.



Comparative Diagrams: Compare the sample with standardized or customized wall charts.

Supported Standards

Grains:
DIN EN ISO 643:2012
ASTM E 112-13 Plate I-IV
GB/T 6394 2017 Plate I-IV

Graphite:
EN ISO 945-1: 2008 + Cor. 1: 2010

Non-metallic inclusion (NMI):
ASTM E45
ISO 4967
GB/T 10561
EN 10247
DIN 50602

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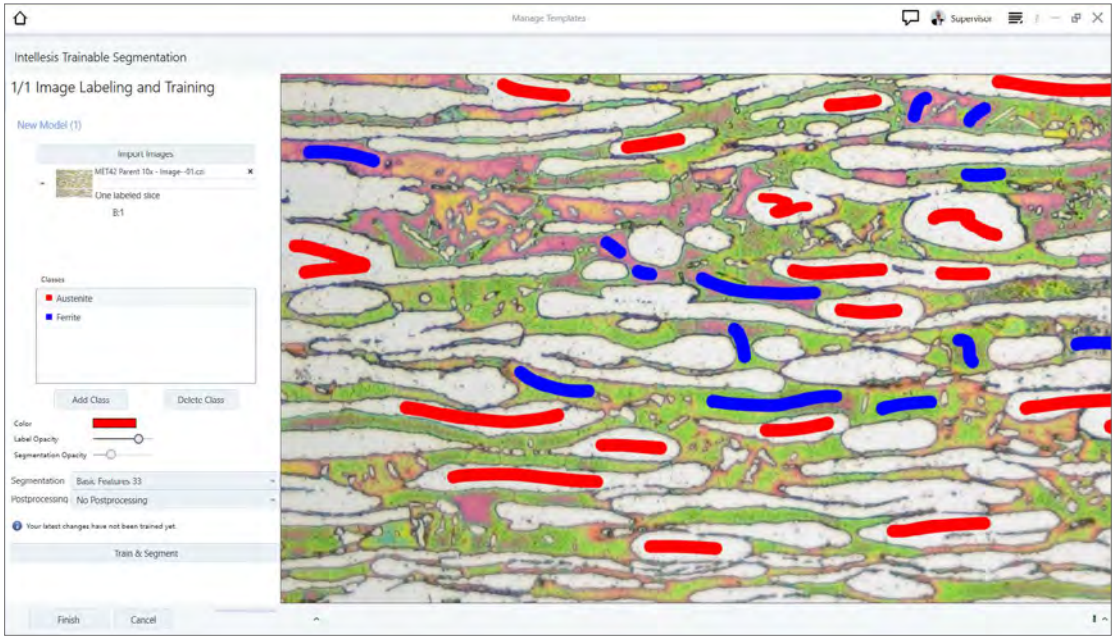
ZEN Intellesis: Image Segmentation by Machine Learning

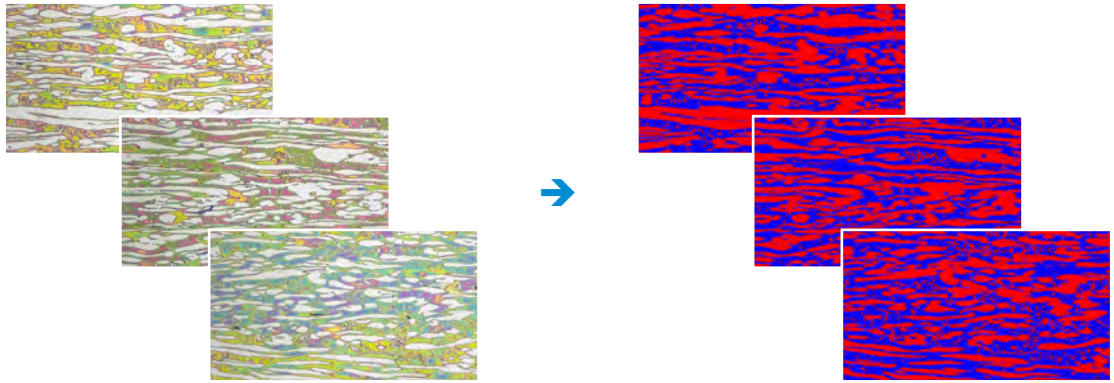
Segmentation is one of the biggest challenges faced by today's microscopists. With image segmentation using machine learning you can avoid errors and influences of user bias.
ZEN Intellesis is your software module for powerful machine learning segmentation of multidimensional images including 3D datasets. You can smoothly integrate multiple imaging modalities or achieve superior segmentation on any single image.

Images that had to be processed manually can now be analyzed automatically, by training ZEN Intellesis to segment them for you, using the straightforward graphical interface. Use your expertise to train the software and let ZEN Intellesis do the tedious segmentation.

You will also benefit from saving sample preparation time, as ZEN Intellesis can adapt to your sample preparation. Reproducibility is guaranteed as the stored analysis program can be re-used sample by sample, or re-trained to handle new samples.



ZEN Intellesis user interface: The user labels a few regions just by painting them in to teach the system how to segment the image.



Once a segmentation model has been trained, it can be re-used, shared, and applied to a bundle of images.

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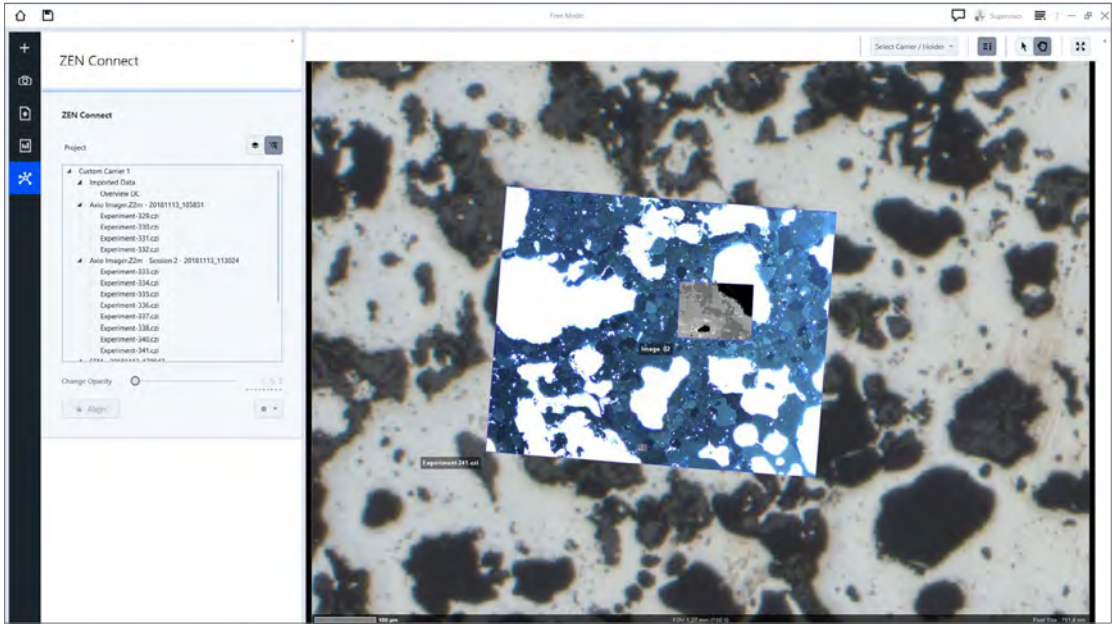
ZEN Connect: Quality Data Put in Context

Organize and visualize different microscopy images and data from the same sample in their context, all in one place. For sample-centric analysis, ZEN Connect workflows enable you to get from a quick overview image to advanced imaging with multipe modalities. The correlations between the images at different scales can be seen and easily navigated. The interdependencies of the different datasets can be stored, exported and re-used in a Client Server Database.
ZEN Connect also enables an integrated reporting across the connected images, videos, and datasets.

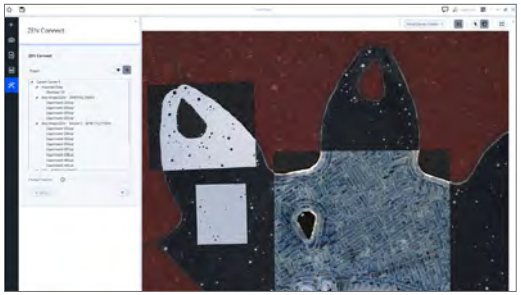
Shuttle & Find: Correlative Microscopy

The ZEISS correlative microscopy interface enables you to seamlessly transfer samples between different light and/or electron microscopes, then quickly and automatically relocate regions of interest to collect maximum relevant data with minimal effort. With Shuttle & Find you can:

- Transfer samples and image data between ZEISS light and electron microscope systems
- Relocate regions of interest automatically
- Improve efficiency and throughput
- Collect the maximum relevant information
- Make well informed material decisions



ZEN Connect user interface



Additively manufactured gear wheel. Imaged on ZEISS Axio Zoom for overview and ZEISS Axio Imager for higher resolution. All images are aligned and well structured in one ZEISS ZEN Connect project. Courtesy of T. Schubert, Aalen University, Germany.

Shuttle & Find: Get more information from light and electron microscopy – together

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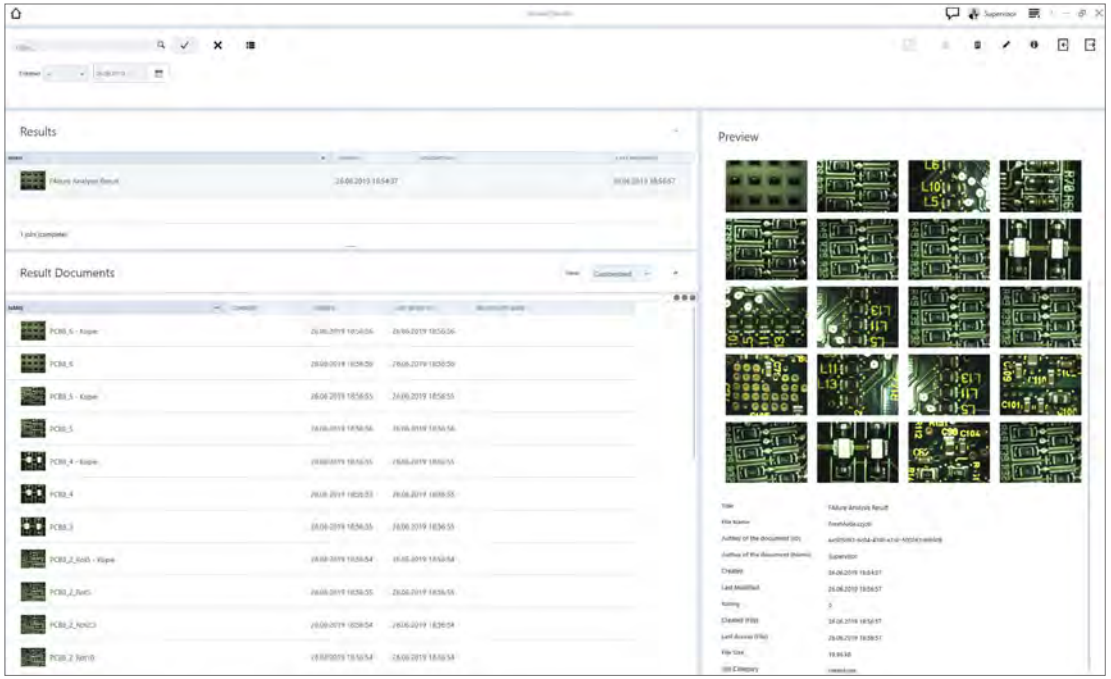
Archive / Database

The Archive or, optionally the Client Server Database, is the storage location for all the results and templates generated with ZEN core. Easily browse and access all results, even those generated from multiple instruments operated via ZEN core. Single station installations can be seamlessly upgraded to multi-station/multi-user database environments.

- Access data collected from individual systems or from multi-modal workflows
- Central storage of results and templates across systems, laboratories and locations
- Upgradable to database and multi-user systems
- In Client Server environments, access to all the result data, templates and workflows from all connected ZEN core clients



Filtering and managing your results in the browse result view of ZEN core

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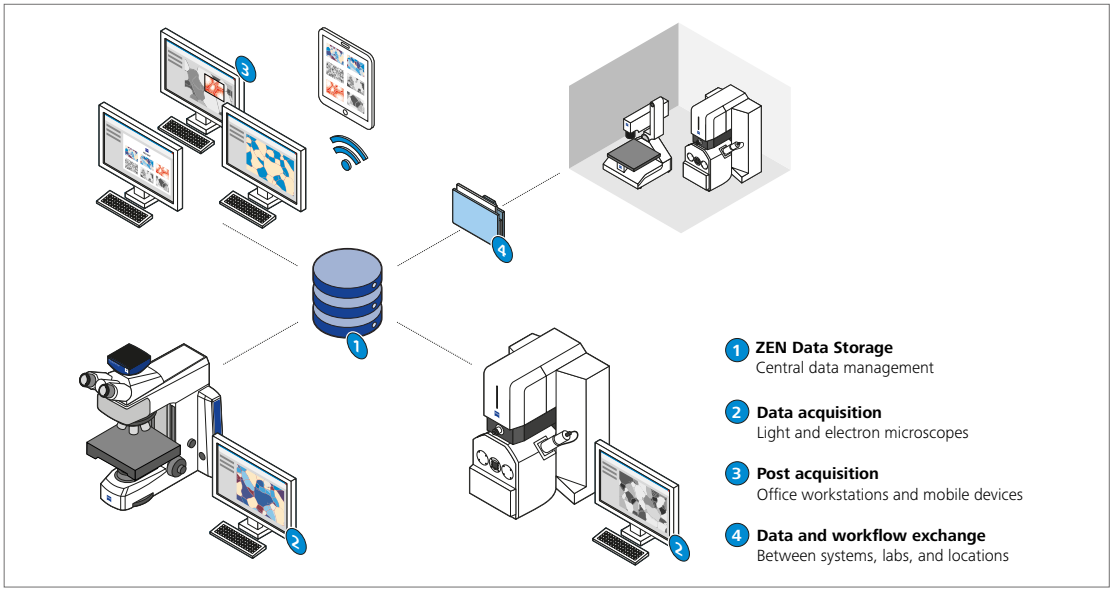
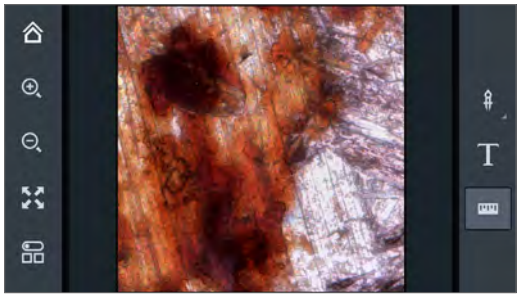
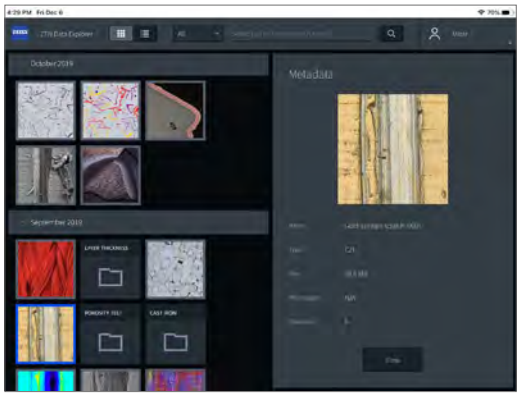
ZEN Data Storage: Central Data Management in the Connected Laboratory

As digitization continues to improve microscopic investigations, you're facing an ever-growing mass of images and data that needs to be managed, all the more so in multi-user laboratories. ZEN Data Storage enables you to separate image and data acquisition from post-acquisition works, making everyone in the lab work more efficiently in a number of ways:

- Experts and non-experts alike can share instrument presets, workflows, data and reports with ease.
- Access to all data from different microscope systems as well as mobile and desktop devices is a given – from different locations, too.
- Access any ZEN Data Storage content with ZEN Data Explorer, a hybrid app for iOS and Android, to browse, view, and annotate images and ZEN core job results.
- Your analyses are quality assured and reproducible.
- With effortless correlation of data from different microscopes, you can perform multi-modal workflows and reap maximum information from your samples.
- You'll also help your IT department implement security and backups.







ZEN Data Explorer: The web-based app, included in the ZEN Data Storage server package, allows to browse, view, and annotate images on smartphones and tablet devices.